# 74LVT16543A

## 3.3 V 16-bit registered transceiver; 3-state

Rev. 4 — 1 April 2021

**Product data sheet** 

### 1. General description

The 74LVT16543A is a 16-bit registered transceiver with 3-state outputs. The device can be used as two 8-bit transceivers or one 16-bit transceiver.

Data flow in each direction is controlled by intput enable (nEAB and nEBA), latch enable (nLEAB and nLEBA), and output enable (nOEAB and nOEBA) inputs. For A to B data flow, the device operates in the transparent mode when (nEAB) and (nLEAB) are LOW. A subsequent LOW-to-HIGH transition of the nLEAB input latches the data and the outputs no longer change with the inputs. A HIGH on either nEAB or nOEAB causes the outputs to assume a high-impedance OFF-state.

Control of data flow from B to A is similar, but using the nEBA, nLEBA, and nOEBA inputs. Bus hold data inputs eliminate the need for external pull-up resistors to define unused inputs

#### 2. Features and benefits

- · 16-bit universal bus interface
- 3-state buffers
- Wide supply voltage range from 2.7 to 3.6 V
- Input and output interface capability to systems at 5 V supply
- Overvoltage tolerant inputs to 5.5 V
- Direct interface with TTL levels
- · BiCMOS high speed and output drive
- Output capability: +64 mA/-32 mA
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- · Live insertion/extraction permitted
- Power-up 3-state
- Power-up reset
- · No bus current loading when output is tied to 5 V bus
- I<sub>OFF</sub> circuitry provides partial Power-down mode operation
- Latch-up performance exceeds 500 mA per JESD 78 Class II Level B
- Complies with JEDEC standards
  - JESD8C (2.7 V to 3.6 V)
- ESD protection:
  - HBM: JESD22-A114F exceeds 2000 V
  - MM: JESD22-A115-A exceeds 200 V

## 3. Ordering information

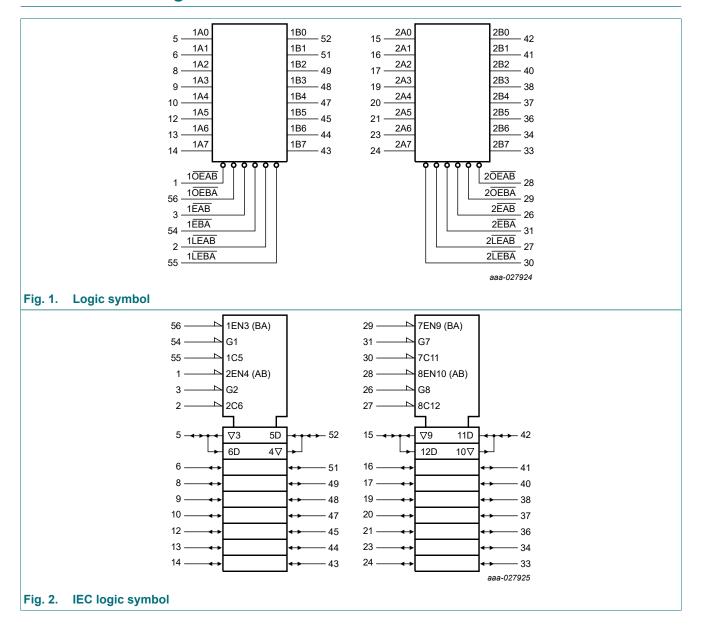
**Table 1. Ordering information** 

Type number	Package										
	Temperature range	Name	Description	Version							
74LVT16543ADGG	-40 °C to +85 °C	TSSOP56	plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1							

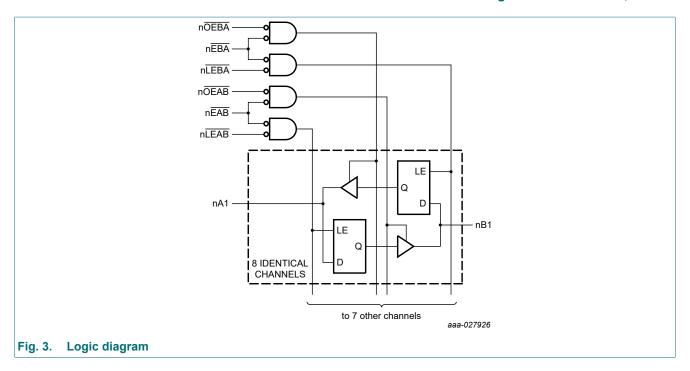


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## 4. Functional diagram



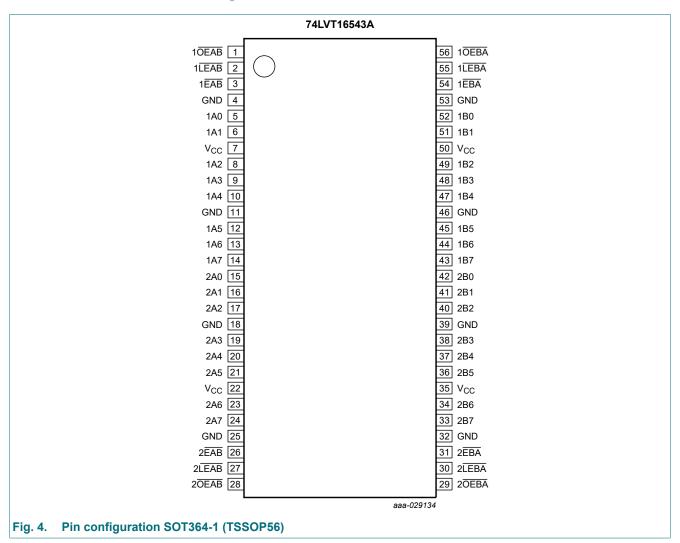
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## 5. Pinning information

### 5.1. Pinning



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## 5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1A0, 1A1, 1A2, 1A3, 1A4, 1A5, 1A6, 1A7	5, 6, 8, 9, 10, 12, 13, 14	data inputs/outputs
2A0, 2A1, 2A2, 2A3, 2A4, 2A5, 2A6, 2A7	15, 16, 17, 19, 20, 21, 23, 24	data inputs/outputs
1B0, 1B1, 1B2, 1B3, 1B4, 1B5, 1B6, 1B7	52, 51, 49, 48, 47, 45, 44, 43	data inputs/outputs
2B0, 2B1, 2B2, 2B3, 2B4, 2B5, 2B6, 2B7	42, 41, 40, 38, 37, 36, 34, 33	data inputs/outputs
1OEAB, 1OEBA, 2OEAB, 2OEBA	1, 56, 28, 29	A to B / B to A output enable inputs (active LOW)
1EAB, 1EBA, 2EAB, 2EBA	3, 54, 26, 31	A to B / B to A enable inputs (active LOW)
1LEAB, 1LEBA, 2LEAB, 2LEBA	2, 55, 27, 30	A to B / B to A latch enable inputs (active LOW)
GND	4, 11, 18, 25, 32, 39, 46, 53	ground (0 V)
Vcc	7, 22, 35, 50	supply voltage

## 6. Functional description

#### **Table 3. Function selection**

H = HIGH voltage level;

 $h = HIGH \ voltage \ level \ one \ set-up \ time \ prior \ to \ the \ LOW-to-HIGH \ transition \ of \ n\overline{LEAB}, \ n\overline{LEBA}, \ n\overline{EAB} \ and \ n\overline{EBA};$ 

L = LOW voltage level;

I = LOW voltage level one set-up time prior to the LOW-to-HIGH transition of  $n\overline{LEAB}$ ,  $n\overline{LEBA}$ ,  $n\overline{EAB}$  and  $n\overline{EBA}$ ;

 $\uparrow$  = LOW-to-HIGH transition of  $n\overline{LEAB}$ ,  $n\overline{LEBA}$ ,  $n\overline{EAB}$  or  $n\overline{EBA}$ ;

X = don't care; NC = no change; Z = high-impedance OFF-state.

Inputs				Outputs	Status	
nOEAB or nOEBA	nEAB or nEBA	nLEAB or nLEBA	nAn or nBn	nBn or nAn		
Н	Х	Х	Х	Z	Disabled	
X	Н	Х	Х	Z	Disabled	
L	1	L	h	Z	Disabled + Latch	
L	↑ L I		Z	Disabled + Latch		
L	L	1	h	Н	Latch + Display	
L	L	1	I	L	Latch + Display	
L	L	L	Н	Н	Transparent	
L	L	L	L	L	Transparent	
L	L	Н	X	NC	Hold	

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## 7. Limiting values

#### **Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+4.6	V
VI	input voltage	[1]	-0.5	+7.0	V
Vo	output voltage	output in OFF or HIGH state [1]	-0.5	+7.0	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0	-50	-	mA
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0	-50	-	mA
Io	output current	output in LOW state	-	128	mA
		output in HIGH state	-64	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature	[2]	-	+150	°C

<sup>[1]</sup> The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

## 8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		2.7	3.6	V
VI	input voltage		0	5.5	V
T <sub>amb</sub>	ambient temperature	in free air	-40	+85	°C
Δt/ΔV	input transition rise and fall rate	outputs enabled	-	10	ns/V

### 9. Static characteristics

#### **Table 6. Static characteristics**

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
V <sub>IK</sub>	input clamping voltage	V <sub>CC</sub> = 2.7 V; I <sub>IK</sub> = -18 mA	-	-0.85	-1.2	V
V <sub>IH</sub>	HIGH-level input voltage		2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage		-	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	$V_{CC}$ = 2.7 V to 3.6 V; $I_{OH}$ = -100 $\mu$ A	V <sub>CC</sub> - 0.2	V <sub>CC</sub>	-	V
		V <sub>CC</sub> = 2.7 V; I <sub>OH</sub> = -8 mA	2.4	2.54	-	V
		V <sub>CC</sub> = 3.0 V; I <sub>OH</sub> = -32 mA	2.0	2.36	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>CC</sub> = 2.7 V; I <sub>OL</sub> = 100 μA	-	0.07	0.2	V
		V <sub>CC</sub> = 2.7 V; I <sub>OL</sub> = 24 mA	-	0.3	0.5	V
		V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 16 mA	-	0.2	0.4	V
		V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 32 mA	-	0.3	0.5	V
		V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 64 mA	-	0.35	0.55	V
I <sub>OH</sub>	HIGH-level output current		-	-	-32	mA

<sup>[2]</sup> The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

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Symbol	Parameter	Conditions		Min	Typ [1]	Max	Unit
I <sub>OL</sub>	LOW-level output current			-	-	32	mA
		current duty cycle ≤ 50 %; f <sub>i</sub> ≥ 1 kHz		-	-	64	mA
$V_{OL(pu)}$	power-up LOW-level output voltage	$V_{CC}$ = 3.6 V; $I_O$ = 1 mA; $V_I$ = $V_{CC}$ or GND	[2]	-	0.13	0.55	V
I <sub>I</sub>	input leakage current	control pins					
		V <sub>CC</sub> = 0 V or 3.6 V; V <sub>I</sub> = 5.5 V		-	0.1	10	μA
		$V_{CC}$ = 3.6 V; $V_{I}$ = $V_{CC}$ or GND		-	0.1	±1	μA
		I/O data pins	[3]				
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 5.5 V		-	0.5	20	μA
		$V_{CC} = 3.6 \text{ V}; V_{I} = V_{CC}$		-	0.5	10	μA
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V		-	1	-5	μA
I <sub>OFF</sub>	power-off leakage current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 0 \text{ V to } 4.5 \text{ V}$		-	1	±100	μA
I <sub>BHL</sub>	bus hold LOW current	V <sub>CC</sub> = 3.0 V; V <sub>I</sub> = 0.8 V		75	130	-	μΑ
I <sub>BHH</sub>	bus hold HIGH current	V <sub>CC</sub> = 3.0 V; V <sub>I</sub> = 2.0 V		-75	-140	-	μA
I <sub>BHLO</sub>	bus hold LOW overdrive current	V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V to 3.6 V	[4]	500	-	-	μΑ
I <sub>BHHO</sub>	bus hold HIGH overdrive current	V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V to 3.6 V	[4]	-	-	-500	μΑ
I <sub>CEX</sub>	output high leakage current	output in HIGH-state when V <sub>O</sub> > V <sub>CC</sub> ; V <sub>O</sub> = 5.5 V; V <sub>CC</sub> = 3.0 V		-	45	125	μΑ
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC} \le 1.2 \text{ V}; V_O = 0.5 \text{ V to } V_{CC};$ $V_I = \text{GND or } V_{CC}; n\overline{OE} = \text{don't care}$	[5]	-	35	±100	μΑ
I <sub>CC</sub>	supply current	$V_{CC} = 3.6 \text{ V}; V_{I} = V_{CC} \text{ or GND}; I_{O} = 0 \text{ A}$					
		outputs HIGH		-	0.07	0.12	mA
		outputs LOW		-	4.5	6	mA
		outputs disabled	[6]	-	0.07	0.12	mA
ΔI <sub>CC</sub>	additional supply current	per input pin; $V_{CC}$ = 3.0 V to 3.6 V; one input = $V_{CC}$ - 0.6 V; other inputs at $V_{CC}$ or GND	[7]	-	0.1	0.2	mA
Cı	input capacitance	at control pins; V <sub>I</sub> = 0 V or 3.0 V		-	3	-	pF
C <sub>I/O</sub>	input/output capacitance		-	9	-	pF	

- All typical values are measured at  $V_{CC}$  = 3.3 V and  $T_{amb}$  = 25 °C. For valid test results, data must not be loaded into the latches after applying power.
- [3] Unused pins at V<sub>CC</sub> or GND.
- [4]
- This is the bus hold overdrive current required to force the input to the opposite logic state. This parameter is valid for any  $V_{CC}$  between 0 V and 1.2 V with a transition time of up to 10 ms. [5]
  - From  $V_{CC}$  = 1.2 V to  $V_{CC}$  = 3.0 V to 3.6 V a transition time of 100  $\mu$ s is permitted. This parameter is valid for  $T_{amb}$  = +25 °C only.  $I_{CC}$  with the outputs disabled is measured with outputs pulled to  $V_{CC}$  or GND. This is the increase in supply current for each input at the specified voltage level other than  $V_{CC}$  or GND.

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## 10. Dynamic characteristics

**Table 7. Dynamic characteristics** 

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V). For test circuit see Fig. 9.

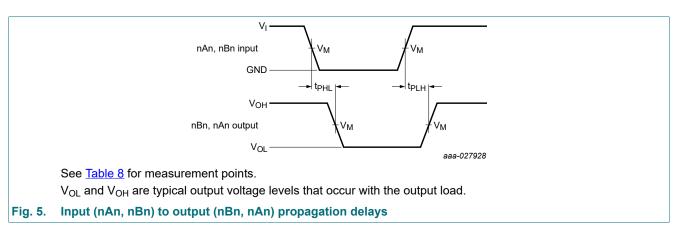
Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
t <sub>pd</sub>	propagation delay	nAn to nBn or nBn to nAn; see Fig. 5 [2]				
		V <sub>CC</sub> = 2.7 V	-	-	4.4	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.0	2.2	3.7	ns
t <sub>pd</sub>	propagation delay	nLEBA to nAn, nLEAB to nBn; see Fig. 6 [2]				
		V <sub>CC</sub> = 2.7 V	-	-	6.2	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	2.7	4.8	ns
t <sub>PZH</sub>	OFF-state to HIGH	nOEBA to nAn, nOEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	6.1	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	2.8	4.6	ns
t <sub>PZL</sub>	OFF-state to LOW	nOEBA to nAn, nOEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	6.6	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	2.6	5.0	ns
t <sub>PHZ</sub>	HIGH to OFF-state	nOEBA to nAn, nOEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.7	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	2.0	3.1	5.2	ns
t <sub>PLZ</sub>	LOW to OFF-state	nOEBA to nAn, nOEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	4.7	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	2.0	3.2	4.6	ns
t <sub>PZH</sub>	OFF-state to HIGH	nEBA to nAn, nEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	6.1	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	2.9	4.8	ns
t <sub>PZL</sub>	OFF-state to LOW	nEBA to nAn, nEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	6.6	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	2.6	5.1	ns
t <sub>PHZ</sub>	HIGH to OFF-state	nEBA to nAn, nEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.7	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	2.0	3.1	5.1	ns
t <sub>PLZ</sub>	LOW to OFF-state	nEBA to nAn, nEAB to nBn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	4.5	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	2.0	3.2	4.3	ns
t <sub>su(H)</sub>	set-up time HIGH	nAn to nLEAB, nBn to nLEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	0.5	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	0.8	0.4	-	ns
t <sub>su(L)</sub>	set-up time LOW	nAn to nLEAB, nBn to nLEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	1.5	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.0	0.1	-	ns
t <sub>h(H)</sub>	hold time HIGH	nAn to nLEAB, nBn to nLEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	0.5	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.0	0.2	-	ns

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Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
t <sub>h(L)</sub>	hold time LOW	nAn to nLEAB, nBn to nLEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	1.3	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.2	0.4	-	ns
t <sub>su(H)</sub>	set-up time HIGH	nAn to nEAB, nBn to nEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	0.4	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	0.7	0.1	-	ns
t <sub>su(L)</sub> so	set-up time LOW	nAn to nEAB, nBn to nEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	1.5	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.3	0.1	-	ns
t <sub>h(H)</sub>	hold time HIGH	nAn to nEAB, nBn to nEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	0.8	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.2	0.2	-	ns
t <sub>h(L)</sub>	hold time LOW	nAn to nEAB, nBn to nEBA; see Fig. 8				
		V <sub>CC</sub> = 2.7 V	1.4	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.3	0.4	-	ns
t <sub>WL</sub>	pulse width LOW	nLEAB and nLEBA; see Fig. 6				
		V <sub>CC</sub> = 2.7 V	1.8	-	-	ns
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.8	1.0	-	ns

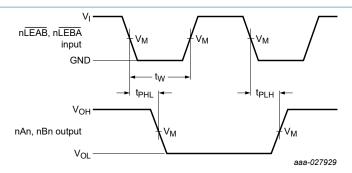
<sup>[1]</sup> Typical values are measured at  $T_{amb}$  = 25 °C and  $V_{CC}$  = 3.3 V

### 10.1. Waveforms and test circuit



<sup>[2]</sup> t<sub>pd</sub> is the same as t<sub>PLH</sub> and t<sub>PHL</sub>

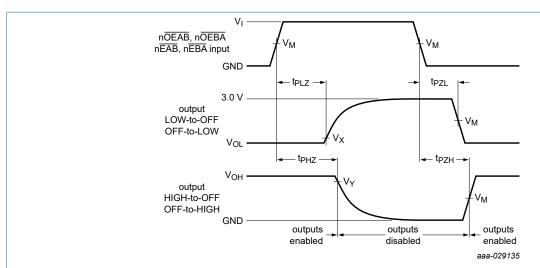
#### 3.3 V 16-bit registered transceiver; 3-state



See Table 8 for measurement points.

 $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

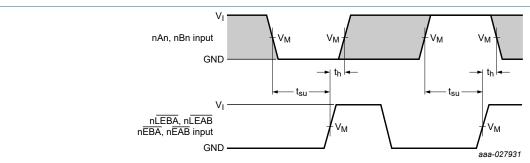
Fig. 6. Input (nLEAB, nLEBA) to output (nBn, nAn) propagation delays and pulse width LOW



See <u>Table 8</u> for measurement points.

V<sub>OL</sub> and V<sub>OH</sub> are typical output voltage levels that occur with the output load.

Fig. 7. 3-state output enable and disable times



See Table 8 for measurement points.

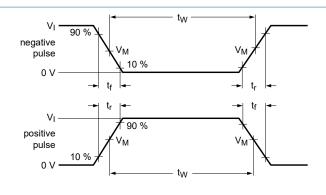
The shaded areas indicate when the input is permitted to change for predictable output performance.

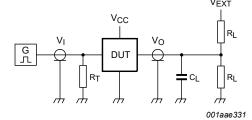
Fig. 8. Data set-up and hold times for the inputs nAn and nBn to nLEBA, nEBA and nEAB inputs

**Table 8. Measurement points** 

Input		Output					
V <sub>I</sub> V <sub>M</sub>		V <sub>M</sub>	V <sub>x</sub>	V <sub>y</sub>			
2.7 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V			

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Test data is given in Table 9.

Definitions test circuit:

R<sub>L</sub> = Load resistance;

 $C_L$  = Load capacitance including jig and probe capacitance;

R<sub>T</sub> = Termination resistance should be equal to output impedance Z<sub>o</sub> of the pulse generator;

 $V_{\text{EXT}}$  = External voltage for measuring switching times.

Fig. 9. Test circuit for measuring switching times

Table 9. Test data

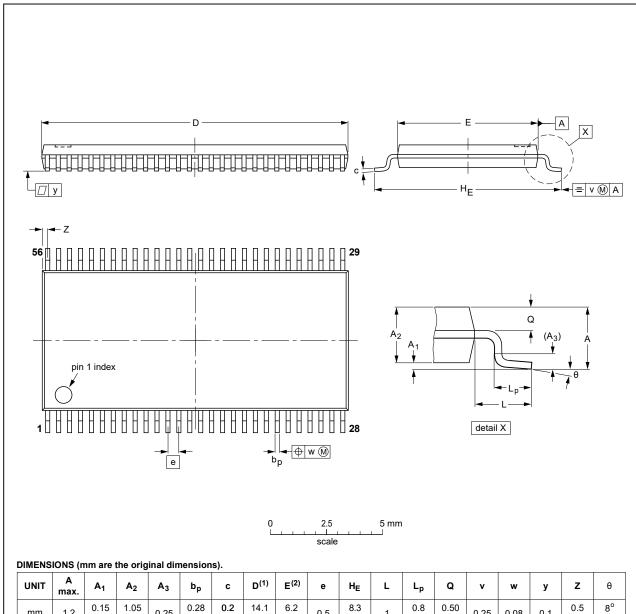
Input				Load		V <sub>EXT</sub>			
V <sub>I</sub>	f <sub>i</sub> t <sub>W</sub>		$t_W$ $t_r, t_f$ $R_L$ $C_L$				t <sub>PLZ</sub> , t <sub>PZL</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	
2.7 V	≤ 10 MHz	500 ns	≤ 2.5 ns	500 Ω	50 pF	GND	6 V	open	

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## 11. Package outline

### TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm

SOT364-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	14.1 13.9	6.2 6.0	0.5	8.3 7.9	1	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.5 0.1	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN	ISSUE DATE	
	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT364-1		MO-153				<del>99-12-27</del> 03-02-19	

Fig. 10. Package outline SOT364-1 (TSSOP56)

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## 12. Abbreviations

#### **Table 10. Abbreviations**

Acronym	Description
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
MM	Machine Model
TTL	Transistor-Transistor Logic

## 13. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LVT16543A v.4	20210401	Product data sheet	-	74LVT16543A v.3	
Modifications:		<ul> <li>Section 1 and Section 2 updated.</li> <li>Type number 74LVT16543ADL (SOT371-1 / SSOP56) removed.</li> </ul>			
74LVT16543A v.3	20181001	Product data sheet	-	74LVT16543A v.2	
Modifications:	guidelines	<ul> <li>The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>			
74LVT16543A v.2	19980219	Product specification	-	74LVT16543A v.1	
74LVT16543A v.1	-	Product specification		-	

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### 14. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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